

IEEE Standard Requirements for Instrument Transformers

IEEE Power Engineering Society

Sponsored by the Transformers Committee

Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual Manual

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Sponsor

Transformers Committee
of the
IEEE Power Engineering Society

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Abstract: Electrical, dimensional, and mechanical characteristics are covered, taking into consideration certain safety features, for current and inductively coupled voltage transformers of types generally used in the measurement of electricity and the control of equipment associated with the generation, transmission, and distribution of alternating current. The aim is to provide a basis for performance and interchangeability of equipment covered and to assist in the proper selection of such equipment. Safety precautions are also addressed. Accuracy classes for metering service are provided. The test code covers measurement and calculation of ratio and phase angle, demagnetization, impedance and excitation measurements, polarity determination, resistance measurements, short-time characteristics, temperature rise tests, dielectric tests, and measurement of open-circuit voltage of current transformers.

Keywords: accuracy, current transformer, instrument transformer, primary winding, rated secondary voltage, routine tests, secondary winding, type tests, voltage transformer

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Introduction

This introduction is not part of IEEE Std C57.13-2008, IEEE Standard Requirements for Instrument Transformers.

This standard was prepared by the Instrument Transformer Subcommittee of the Transformers Committee of the IEEE Power Engineering Society. The purpose of this standard is to cover the electrical, dimensional, and mechanical characteristics and to take into consideration certain safety features, for current and inductively coupled voltage transformers.

The changes in this revision of this standard are to the rated voltage rating of voltage transformers to eliminate the confusion caused by the specification of the primary voltage and the system voltage for line to ground transformers. An addition of partial discharge testing was added to the test section.

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Contents

1. Overview	1
1.1 Scope	1
1.2 Purpose	1
2. Normative references	2
3. Definitions	2
4. General requirements	3
4.1 Service conditions	3
4.2 Effect of air density on flashover voltage	4
4.3 Frequency	4
4.4 Effect of altitude on temperature rise and effect of ambient temperature on permissible loading	5
4.5 Basic impulse insulation levels, dielectric tests, and outdoor instrument transformer creepage distance and wet tests	5
4.6 Temperature rise	8
4.7 Tests	9
4.8 Construction	10
5. Accuracy classes for metering	12
5.1 Basis for accuracy classes	12
5.2 Expression of Transformer Correction Factor at 0.6 power factor (lagging) of metered load	13
5.3 Standard accuracy classes	13
5.4 Limiting values of Ratio Correction Factor and phase angle for standard accuracy classes	13
6. Current transformers	15
6.1 Terms in which ratings shall be expressed	15
6.2 Standard burdens	15
6.3 Accuracy ratings for metering	16
6.4 Accuracy ratings for relaying	18
6.5 Continuous thermal current rating factors based on 30 °C average ambient air temperature	19
6.6 Short time current ratings	19
6.7 Secondary winding-induced voltages	20
6.8 Nameplates	21
6.9 Terminals	21
6.10 Application data	21
6.11 Routine accuracy tests	23
7. Voltage transformers	23
7.1 Terms in which ratings shall be expressed	23
7.2 Standard burdens	29
7.3 Accuracy ratings	30

	7.4 Thermal burden ratings	30
	7.5 Nameplates	30
	7.6 Terminals	31
	7.7 Short-circuit capability	31
	7.8 Application data	31
	7.9 Induced voltage test	31
	7.10 Routine accuracy tests	32
8.	Test code	32
	8.1 Ratio and phase angle measurement and calculations	32
	8.2 Demagnetization	50
	8.3 Impedance and excitation measurements	52
	8.4 Polarity	57
	8.5 Resistance measurements	60
	8.6 Short-time characteristics	62
	8.7 Temperature rise tests	66
	8.8 Dielectric tests	70
	8.9 Measurement of open-circuit voltage of current transformers	74
	8.10 Partial discharge measurement	76
۸.	nney A (informativa) Ribliography	80



IEEE Standard Requirements for Instrument Transformers

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1. Overview

1.1 Scope

This standard is intended for use as a basis for performance and interchangeability of equipment covered, and to assist in the proper selection of such equipment. Safety precautions are also addressed.

This standard covers certain electrical, dimensional, and mechanical characteristics, and takes into consideration certain safety features of current and inductively coupled voltage transformers of types generally used in the measurement of electricity and the control of equipment associated with the generation, transmission, and distribution of alternating current.

1.2 Purpose

The purpose of this standard is to provide the performance requirements for electrical system and test interchangeability of current and inductively coupled voltage transformers. These transformers are for both indoor and outdoor application.